

PIC18(L)F24/25K42

PIC18(L)F24/25K42 Silicon Errata and Data Sheet Clarification

The PIC18(L)F24/25K42 devices that you have received conform functionally to the current Device Data Sheet (DS40001869**E**), except for the anomalies described in this document.

The silicon issues discussed in the following pages are for silicon revisions with the Device and Revision IDs listed in Table 1. The silicon issues are summarized in Table 2.

The errata described in this document will be addressed in future revisions of the PIC18(L)F24/25K42 silicon.

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated in the last column of Table 2 apply to the current silicon revision (A4).

Data Sheet clarifications and corrections start on page 12, following the discussion of silicon issues.

The silicon revision level can be identified using the current version of MPLAB® IDE and Microchip's programmers, debuggers, and emulation tools, which are available at the Microchip corporate website (www.microchip.com).

For example, to identify the silicon revision level using MPLAB IDE in conjunction with a hardware debugger:

- 1. Using the appropriate interface, connect the device to the hardware debugger.
- 2. Open an MPLAB IDE project.
- Configure the MPLAB IDE project for the appropriate device and hardware debugger.
- 4. For MPLAB X IDE, select <u>Window > Dashboard</u> and click the **Refresh Debug Tool Status** icon ().
- 5. Depending on the development tool used, the part number *and* Device Revision ID value appear in the **Output** window.

Note: If you are unable to extract the silicon revision level, please contact your local Microchip sales office for assistance.

The DEVREV values for the various PIC18(L)F24/25K42 silicon revisions are shown in Table 1.

TABLE 1: SILICON DEVREV VALUES

Part Number	Device ID<13:0> ^{(1), (2)}	Revision	Revision	
Part Number	Device ID<13:0>(*); (=)	A1	A4	
PIC18F24K42	6CA0h	A001	A002	A004
PIC18LF24K42	6DE0h	A001	A002	A004
PIC18F25K42	6C80h	A001	A002	A004
PIC18LF25K42	6DC0h	A001	A002	A004

- **Note 1:** The Revision ID is located in addresses 3FFFFCh-3FFFDh and the Device ID is located in addresses 3FFFEh-3FFFFh.
 - **2:** Refer to the "PIC18(L)F24/25K42 Memory Programming Specification" (DS40001836) for detailed information on Device and Revision IDs for your specific device.

TABLE 2: SILICON ISSUE SUMMARY

Module	Feature	Item No.	Issue Summary		Affecte	
		NO.		A 1	A2	A4
Direct Memory			Х			
Access (DMA)	DMA in Doze mode	1.2	DMA transfers may not work when CPU is in Doze mode.	Х	Х	Х
	ADC RC oscillator	2.1	ADC RC oscillator not functional.	Χ		
Analog-to-Digital	ADC conversion	2.2	The 12-bit ADC shorts briefly at the beginning of the ADC conversion stage.	X		
Converter with Computation (ADC2)	Burst Average mode Double Sampling	2.3	The ADC ² does not trigger the second conversion when operated in non-continuous double-sampling Burst Average mode.	X	х	Х
	ADC conversion in Fosc mode	2.4	ADC does not complete conversion successfully in Fosc mode.	X	Х	
	Flow control PPS	3.1	Flow control affected by PPS.	Χ	Χ	Х
	Flow control transmit driver	3.2	Flow control transmit driver enable (TXDE) is low true.	Х		
	DALI mode auto- baud	3.3	DALI mode always auto-bauds on the Start bit.	X		
	BRGS select	3.4	BRGS select feature not functional in DALI mode.		Х	Х
Universal Asynchronous Receiver Transmitter (UART)	Stop bit interrupt flag	3.5	Stop bit interrupt flag functionality not available.	Х		
	DMX mode make after break	3.6	Make after Break period is less than required by the DMX specification.			
	RXIDL Status bit	3.7	RXIDL remains clear after auto-baud overflow.	Х		
	TXMTIF interrupt flag	3.8	TXMTIF flag is delayed by two instruction cycles.	X		
	Auto-baud	3.9	The first character after auto-baud may be corrupted.	X	Х	Х
	Multi-Host mode transmission	4.1	Multi-Host mode transmission.	X		
	10-bit Host mode reception	4.2	Automatic restart in 10-bit Host reception.	X	Х	Х
	NACKIF interrupt flag	4.3	Operation of the NACKIF flag.	X		
I2C	Auto-count	4.4	Auto-count feature in Host Reception mode.	Χ	X ⁽²⁾	X ⁽²⁾
	TXIF interrupt flag	4.5	The TXIF flag is set for 7/10 bit reads when ADBDIS = 1.	Х	X ⁽²⁾	X ⁽²⁾
	I ² C receive buffer	4.6	Received data is transferred into the I2CxRXB buffer on an incorrect clock edge.	Х	Х	Х
	I ² C Start/Stop Flags	4.7	I ² C Start and/or Stop flags may be set when I ² C is enabled.	Х	Х	Х
Program Flash Memory	Endurance of PFM cell for LF devices	5.1	Endurance of the PFM cell is lower than specified.		Х	Х
Signal Measurement Timer (SMT)	MFINTOSC clock sources into SMT	6.1	MFINTOSC clock sources into the SMT are not functional.	Х	Х	Х

TABLE 2: SILICON ISSUE SUMMARY (CONTINUED)

Module	Feature	Item	Issue Summary		Affecte visions	-
		NO.		A 1	A2	A4
	SMBus 2.0	7.1	SMBus 2.0 logic levels.	Х		
	SMBus 3.0	7.2	SMBus 3.0 logic levels.	Χ	Χ	Х
Electrical Specifications	Min V _{DD} specification	7.3	Device may not work properly at certain voltage levels and temperatures.	Х	Х	Х
	Fixed Voltage Reference (FVR) accuracy	7.4	FVR output tolerance may be higher than specified at temperatures below -20°C.	X	X	х
Nonvolatile Memory (NVM) Control	The WRERR bit functionality	8.1	The WRERR bit cannot be cleared in hardware after being set once.	Х	Х	Х
Windowed Watchdog Timer (WWDT)	WWDT operation in Doze mode	9.1	Window violation occurs when WWDT operated in Doze mode.	x	X	х
Power-Saving Operation Modes	Low-Power Sleep mode	10.1	Low-Power Sleep mode does not operate at 3.1V < VDD < 3.3V.	X	X	
Instruction Set	MOVFF/MOVSF instruction	11.1	MOVFF/MOVSF may corrupt destination.	X	X	Х
In-Circuit Debugging (ICD)	Software breakpoints	12.1	Software breakpoints are not available.	Х	Х	Х

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

^{2:} I²C issues exist only in 10-bit Addressing mode. Fixed in 7-bit Addressing mode.

Silicon Errata Issues

Note:

This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated by the shaded column in the following tables apply to the current silicon revision (A4).

1. Module: Direct Memory Access (DMA)

1.1 Hard Stop

When a DMA transaction is stopped in the middle of the transfer (the XIP bit is set) by clearing the Enable bit (hard stop), the destination address can be written to with 0×0.0 . This only happens if the very next cycle (after clearing enable) can provide the DMA access to the SRAM bus.

Work around

Clearing the DGO bit before hard stop will prevent the destination being written to with 0×00 .

Affected Silicon Revisions

A1	A2	A4			
Χ					

1.2 DMA in Doze Mode

When the CPU is operated in Doze mode, DMA transfers may not work as expected.

Work around

None.

Affected Silicon Revisions

A 1	A2	A4			
Χ	Х	Х			

2. Module: Analog-to-Digital Converter with Computation (ADC²)

2.1 ADC RC Oscillator

Incorrect ADC operation when using clock supplied from dedicated FRC oscillator (i.e., the CS bit is set in the ADCON0 register).

Work around

Use ADC clock supplied by Fosc for ADC operation.

Affected Silicon Revisions

A1	A2	A4			
Χ					

2.2 ADC Conversion

At the very beginning of the ADC conversion, the input signal may briefly be pulled to ground, which in turn may take some charge out of the internal Sample-and-Hold capacitor. The problem is more pronounced on inputs with an impedance greater than 1 kOhm.

This issue will be seen when sampling the following internal channel inputs: FVR, DAC, and Temperature Indicator and when sampling external sources on an analog pin, including the CVD.

Work around

- When sampling the internal channel inputs, FVR, DAC, and Temperature Indicator, increase the minimum TAD time to 4 μs to increase accuracy.
- b) When sampling an external source through an analog pin, keep the input impedance below 1 kOhm.
- When using the ADC in CVD mode, there is no work around.

A 1	A2	A4			
Χ					

2.3 Burst Average Mode Double Sampling

When the ADC^2 is operated in Burst Average mode (MD = 0 ± 0.011 in the ADCON2 register) while enabling non-continuous operation and double-sampling (CONT = 0 in the ADCON0 register and DSEN = 1 in the ADCON1 register), the value in the ADCNT register does not increment beyond 0 ± 1 toward the value in the ADRPT register.

Work around

When operating the ADC^2 in Burst Average mode with double-sampling, enable continuous operation of the module (CONT = 1 in the ADCON0 register) and set the Stop-On-Interrupt bit (SOI in the ADCON3 register). After the interrupt occurs, perform appropriate threshold calculations in the software and retrigger ADC^2 as necessary.

If the CPU is in Low-Power Sleep mode, alternatively the ADC^2 in non-continuous Burst Average mode can be operated with single ADC conversion (DSEN = 0 in the ADCON1 register) compromising noise immunity for lower power consumption by preventing the device from waking up to perform threshold calculations in the software.

Affected Silicon Revisions

A1	A2	A4			
Χ	Х	Х			

2.4 ADC Conversion in Fosc Mode

The ADCON0.GO bit remains set and the conversion does not complete successfully when configured to operate in Fosc mode (ADCON0.CS = 0) with Fosc > 40 MHz.

Work around

Use ADCRC as the ADC clock source (ADCON0.CS = 1).

Affected Silicon Revisions

A 1	A2	A4			
Χ	Х				

3. Module: Universal Asynchronous Receiver Transmitter (UART)

3.1 Flow Control PPS

Unimplemented PPS input selections for UART1 and UART2 may interfere with hardware flow control when that feature is enabled.

Work around

Set SFRs 0x3AE7 and 0x3AEA to 0x18.

Affected Silicon Revisions

A1	A2	A4			
Χ	Χ	Χ			

3.2 Flow Control Transmit Driver

The TXDE output is active-low, whereas the DE input of RS-485 transceivers need an active-high signal to enable the transmit drivers.

Work around

Use PPS to route TXDE to a pin and then use a CLC module to input and invert the signal on that pin, and use PPS to output that CLC to another pin.

Affected Silicon Revisions

A1	A2	A4			
Х					

3.3 DALI Mode Auto-Baud

The auto-baud feature is always enabled in DALI mode in revision A1, regardless of the value of the ABDEN control bit. This will adversely affect data reception when the mid-bit transition of the Manchester data is offset by more than 14%.

Work around

None in revision A1. The auto-baud feature is disabled in DALI mode in revision A2.

A 1	A2	A4			
Х					

3.4 Baud Rate Generator Speed Select

The Baud Rate Generator Speed Select feature (the BRGS bit in the UxCON0 register) in DALI mode is not functional. The Baud Rate Generator always operates at normal speed with 16 baud clocks per bit in DALI mode.

Work around

When using UART in DALI mode, operate the Baud Rate Generator in normal speed (BRGS = 0) only and use the following formula to calculate the UxBRGH:L register value:

$$UxBRGH:L = \frac{FOSC}{16 \times Desired Baud Rate} - 1$$

Example: To obtain the desired baud rate of 1200 at Fosc = 64 MHz,

$$UxBRGH:L = \frac{64,000,000}{16 \times 1200} - 1 = 3332$$

Affected Silicon Revisions

A1	A2	A4			
	Х	Х			

3.5 Stop Bit Interrupt Flag

Stop bit interrupt flag functionality is not available in the CERIF bit in revision A1.

Work around

Use Timer2 with HLT and connect the UART RX port to the timer Reset trigger. Set the time-out period to the desired Stop bit time (for DALI mode, this is equivalent to two Stop bits at 1200 baud = 1.66 ms). When the Stop bit is received, the timer times out notifying end of data.

Affected Silicon Revisions

A 1	A2	A4			
Х					

3.6 DMX Mode Make After Break

In DMX Console mode, the MAB period is 8 µs. The specification requires a minimum of 12 µs.

Work around

The UART uses only the BREAK time to determine the start of a new frame. Therefore, the short MAB period does not affect DMX operation when using this UART as equipment and no work around is required. However, equipment using other devices for reception may be affected, in which case 8-bit Asynchronous mode must be used with software control of all of the DMX console operations.

Affected Silicon Revisions

A1	A2	A4			
Χ					

3.7 RXIDL Status Bit

The RXIDL bit properly stays low until the 5th rising edge after auto-baud starts. If auto-baud overflows and is subsequently cleared by software, then RXIDL improperly remains low until the 5th rising edge.

Work around

If RXIDL is low after an auto-baud overflow, then cycle the RXEN or ON bit to restore normal operation.

Affected Silicon Revisions

A 1	A2	A4			
Χ					

3.8 TXMTIF Interrupt Flag

The TXMTIF flag goes low two instruction cycles after the TXB register is written. The bit cannot be polled or interrupt enabled immediately after writing the TXB register.

Work around

Allow at least two instruction cycles after writing TXB before enabling the TXMTIF interrupt or starting to poll the TXMTIF flag.

A 1	A2	A4			
Х					

3.9 Auto-Baud

When the UART is configured as follows, then the first character received after auto-baud may be corrupted:

- The UBRG registers are cleared.
- The BRGS bit is set (Fast Baud Rate mode).
- The Stop bits are configured for two Stop bits (STP = 0b1x).

Work around

- a) In asynchronous modes other than LIN: The transmitter may delay the first character by at least one character period after sending autobaud
- In all asynchronous modes including LIN: Clear the BRGS bit to select the normal baud rate mode.

Affected Silicon Revisions

A 1	A2	A4			
Х	Х	Х			

4. Module: l²C

4.1 Multi-Host Mode Transmission

When the I^2C is configured in Multi-Host mode and is operating in Client Transmission mode, writes to the transmit buffer will set the S (Start) bit in the I2CxCON0 register. When the bus becomes free (i.e., BFRE = 1) after client transmission is complete, then the multi-host behaves as a host and initiates a transaction. The host will either send the content of address buffer (ADBDIS = 0) or transmit buffer (ADBDIS = 1).

Work around

Clear the Start bit just before the Stop condition of client transmission occurs; this prevents a false addressing sequence on the I²C Bus.

Affected Silicon Revisions

A1	A2	A4			
Χ					

4.2 10-Bit Host Mode Reception

When ADBDIS = 1, user software writes to the transmit buffer with the client address. After the addressing sequence is complete, the user software writes the read address to the transmit buffer, while the host is paused for restart (i.e., MDR = 1 & I2CCNT = 0 & MMA = 1). However, a restart does not occur when the transmit buffer is written to.

Work around

The user has to load the transmit buffer and additionally set the S (Start) bit to initiate the restart sequence.

Affected Silicon Revisions

A 1	A2	A4			
Χ	Χ	Χ			

4.3 NACKIF Interrupt Flag

The NACKIF flag is set on the client even if the host transmits a non-matching client address.

Work around

Enable NACKIE only when SMA = 1 to avoid unwanted interrupts.

A1	A2	A4			
Χ					

4.4 Auto-Count

When the ACNT bit in the I2CxCON2 register is set before the host transmits the high address byte, then the MDR bit is set after the 8th SCL pulse, preventing the completion of the addressing sequence.

Work around

Set the ACNT bit after the addressing sequence is complete and when the host is paused for restart (i.e., MDR = 1 & I2CCNT = 0 & MMA = 1).

Affected Silicon Revisions for 7-bit Addressing Mode

A 1	A2	A4			
Χ					

<u>Affected Silicon Revisions for 10-bit</u> <u>Addressing Mode</u>

A 1	A2	A4			
Χ	Х	Х			

4.5 TXIF Interrupt Flag

When ADBDIS = 1, the address is sent through the transmit buffer. Even if it is a read address, the TXIF flag is set as the data was moved out of the transmit buffer.

Work around

For I^2C host read, ignore the TXIF flag if ADBDIS = 1.

<u>Affected Silicon Revisions for 7-bit Addressing</u> Mode

A 1	A2	A4			
Χ					

Affected Silicon Revisions for 10-bit Addressing Mode

A 1	A2	A4			
Χ	Χ	Χ			

4.6 I²C Receive Buffer

When receiving data into the receive buffer I2CxRXB, the byte is transferred into the buffer on the 9th rising clock edge rather than the expected 8th falling edge. This causes both the Receive Buffer Full (RXBF) status bit and the Receive Buffer Interrupt Flag (I2CxRXIF) to also be set on the 9th rising clock edge. The Data Write Interrupt (WRIF) and Address Interrupt Flag (ADRIF) will still be set on the 8th falling clock edge. If user software is configured to interrupt (or poll) when either the WRIF bit or the ADRIF bit is set, hardware will read an empty receive buffer, set the Receive Read Error (RXRE) status flag, and a NACK will be issued.

Work around

Do not use WRIF or ADRIF to determine when the receive buffer has received data. Instead, interrupt/poll using the I2CxRXIF interrupt bit or poll the RXBF bit. These bits are correctly set once the address/data byte has been transferred into I2CxRXB.

A 1	A2	A4			
Χ	Х	Х			

4.7 I²C Start and/or Stop Flags May be Set When I²C is Enabled

When I²C is enabled, erroneous Start and/or Stop conditions may be detected. This can generate erroneous I²C interrupts if enabled.

Work around

Use the following procedure to correctly detect the Start and Stop conditions:

- Disable Start and Stop conditions interrupt functions.
- 2. Enable I²C module.
- 3. Wait 250 ns + 6 instruction cycles (Fosc/4).
- 4. Clear the Start and Stop conditions interrupt flags.
- Enable Start and Stop conditions interrupt functions if used.

```
I2CxPIEbits.SCIE = 0;
I2CxPIEbits.PCIE = 0;
I2CxCONObits.EN = 1;
Delay();
I2CxPIRbits.SCIF = 0;
I2CxPIRbits.PCIF = 0;
I2CxPIEbits.PCIE = 1;
```

Affected Silicon Revisions

A 1	A2	A4			
Χ	Χ	Χ			

5. Module: Program Flash Memory

5.1 Endurance of PFM Cell for LF Devices

The Flash memory cell endurance specification (Parameter MEM30) for PIC18LF24/25K42 devices is 1K cycles.

Work around

None.

Affected Silicon Revisions

A 1	A2	A4			
Χ	Χ	Х			

6. Module: Signal Measurement Timer (SMT)

6.1 MFINTOSC Clock Sources into SMT

The Signal Measurement Timer does not operate when the MFINTOSC is selected as the clock source (i.e., CSEL = 0b100 and 0b101). The MFINTOSC does not start up automatically.

Work around

User software needs to manually enable the MFINTOSC by setting the MFOEN bit in the OSCCEN register. The MFINTOSC will remain enabled as long as the MFOEN bit is set.

Affected Silicon Revisions

A1	A2	A4			
Χ	Х	Х			

7. Module: Electrical Specifications

7.1 SMBus 2.0

The SMBus 2.0 VIL specification (Parameter D304) at 125°C is 0.7V.

Work around

None.

Affected Silicon Revisions

A 1	A2	A4			
Χ					

7.2 SMBus 3.0

The SMBus 3.0 V_{IL} specification (Parameter D305) is temperature and V_{DD} dependent. Refer to the table below.

Temperature	V DD	D305 SMBus 3.0 VIL Specification
-40°C	1.8V	0.6V
-40°C	5.5V	0.8V
25°C	1.8V	0.6V
25°C	5.5V	0.8V
85°C	1.8V	0.6V
85°C	5.5V	0.7V
125°C	1.8V	0.5V
125°C	5.5V	0.7V

Work around

None.

A1	A2	A4			
Х	Χ	X			

7.3 Min VDD Specification for LF Devices

VDDMIN for LF devices has changed for temperatures below +25°C as shown below in **bold**.

PIC18LF	24/25K4	2	Standa	Standard Operating Conditions (unless otherwise stated)					
PIC18F2	24/25K42								
Param. No.	Sym.	Characteristic	Min.	Typ.†	Max.	Units	Conditions		
Supply '	Voltage								
D002	VDD		2.3 1.8 2.5 2.7	_ _ _	3.6 3.6 3.6 3.6	V V V	Fosc ≤ 16 MHz (-40°C to <+25°C) Fosc ≤ 16 MHz (≥+25°C to +125°C) Fosc > 16 MHz and Fosc ≤ 32 MHz Fosc > 32 MHz		
D002	VDD		2.3 2.5 2.7	_ _ _	5.5 5.5 5.5	V V V	Fosc ≤ 16 MHz Fosc > 16 MHz and Fosc ≤ 32 MHz Fosc > 32 MHz		

Work around

None.

Affected Silicon Revisions

A1	A2	A4			
Χ	Х	Х			

7.4 Fixed Voltage Reference (FVR) Accuracy

At temperatures below -20°C, the output voltage for the FVR may be greater than the levels specified in the data sheet. This will apply to all three gain amplifier settings (1X, 2X, 4X). The affected parameter numbers found in the data sheet are: FVR01 (1X gain setting), FVR02 (2X gain setting), and FVR03 (4X gain setting).

Work around

At temperatures above -20°C, the stated tolerances in the data sheet remain in effect. Operate the FVR only at temperatures above -20°C.

Affected Silicon Revisions

A 1	A2	A4			
Х	Х	Х			

8. Module: Nonvolatile Memory (NVM) Control

8.1 WRERR Bit Functionality

When a Reset is issued while an NVM high-voltage operation is in progress, the WRERR bit in the NVMCON1 register is set as expected. After clearing the WRERR bit, if a Reset reoccurs, the WRERR bit is set again regardless of whether an NVM operation is in progress or not.

Work around

None.

Affected Silicon Revisions

A 1	A2	A4			
Χ	Χ	Х			

9. Module: Windowed Watchdog Timer (WWDT)

9.1 WWDT Operation in Doze Mode

When the CLRWDT instruction is issued in Doze mode, a window violation error occurs in WWDT even though the window is open and armed.

Work around

Do not operate the WWDT in Doze mode.

A 1	A2	A4			
Х	Χ	Χ			

10. Module: Power-Saving Operation Modes

10.1Low-Power Sleep Mode in F Devices

The F device resets when waking up from Sleep while in Low-Power mode (VREGPM = 1 in the VREGCON register) at 3.1V < VDD < 3.3V.

Work around

- a) If wake-up from Sleep is needed at 3.1V < VDD < 3.3V, operate the F device in Normal Power mode (VREGPM = 0).
- b) If wake-up from Sleep is needed at 3.1V < VDD < 3.3V, enable the Fixed Voltage Reference (EN = 1 in the FVRCON register). This increases the current in Sleep mode by typically 7 μ A.

Affected Silicon Revisions

A 1	A2	A4			
Х	Х				

11. Module: Instruction Set

11.1 MOVFF/MOVSF Instruction

When the BSR points to the last bank of the SFR region (BSR = $0 \times 3 F$) and the low byte of the source or destination address of a MOVFF/MOVSF instruction equals the low byte of an indirect addressing operation register address (INDFx, POSTINCx, POSTDECx, PREINCx, PLUSWx), the operation will not be completed as expected. Either, one or more of the destination, FSR value, or location pointed to by the FSR will be corrupted, or the move will simply not occur.

Work around

Ensure that the BSR does not point to the last bank of the SFR region (BSR = $0 \times 3F$) when the MOVFF/MOVSF instruction is being executed.

Affected Silicon Revisions

A 1	A2	A4			
Χ	Χ	Χ			

12. Module: In-Circuit Debugging (ICD)

12.1Software Breakpoints

When debugging code, software breakpoints will not be available.

Work around

None.

A 1	A2	A4			
Χ	Χ	Χ			

Data Sheet Clarifications

The following typographic corrections and clarifications are to be noted for the latest version of the device data sheet (DS40001869**E**):

Note: Corrections are shown in **bold**. Where possible, the original bold text formatting has been removed for clarity.

1. Module: Electrical Specifications

Figure 44-5 incorrectly shows the location of parameters OS1, OS2, OS3, OS4, OS5, OS6, OS7, OS8, OS9, OS10, OS20 and OS21. The correct location for the above-mentioned parameters is depicted in the following figure.

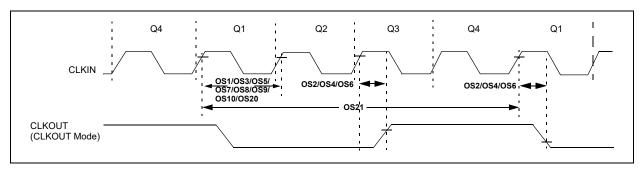


Figure 44-5 Clock Timing

2. Module: Nonvolatile Memory (NVM) Control

Section 13.2 incorrectly states the writing access for User IDs. The corrected Section 13.2 is shown below with changes highlighted in **bold**.

2.1 Device Information Area, Device Configuration Area, User ID, Device ID and Configuration Word Access

When REG[1:0] = 0b01 or 0b11 in the NVMCON1 register, the Device Information Area, the Device Configuration Area, the User IDs, Device ID/ Revision ID and Configuration Words can be accessed. Different access may exist for reads and writes (see Table 13-1).

2.1.1 Reading Access

The user can read from these blocks by setting the REG bits to 0b01 or 0b11. The user needs to load the address into the TBLPTR registers. Executing a TBLRD instruction after that moves the byte pointed to the TABLAT register. The CPU operation is suspended during the read and resumes after. When read access is initiated on an address outside the parameters listed in Table 13-1, the TABLAT register is cleared, reading back '0's.

2.1.2 Writing Access

Only the User IDs and CONFIG words have write access enabled. The user can write to these blocks by setting the REG bits to 0b01 or 0b11.

The WREN bit in NVMCON1 must be set to enable writes. This prevents accidental writes to the **User IDs/** CONFIG words due to errant (unexpected) code execution. WREN must be kept clear at all times, except when updating the **User IDs/**CONFIG words. WREN is not cleared by hardware. The WR bit will be inhibited from being set unless the WREN bit is set.

2.1.2.1 Writing to CONFIG Words

The user needs to load the TBLPTR and TABLAT registers with the address and data byte respectively before executing the write command. An unlock sequence needs to be followed for writing to the **CONFIG** words (Section 13.1.4, NVM Unlock Sequence). If WRTC = 0 or if TBLPTR points to an invalid address location (see Table 13-1), the WR bit is cleared without any effect and WRERR is set.

A single CONFIG word byte is written at once and the operation includes an implicit erase cycle for that byte (it is not necessary to set FREE). CPU execution is stalled and, at the completion of the write cycle, the WR bit is cleared in hardware and the NVM Interrupt Flag (NVMIF) bit is set. The new CONFIG value takes effect when the CPU resumes operation.

2.1.2.2 Writing to User IDs

The user needs to load the TBLPTR and TABLAT registers with the address and data byte respectively. Writing to the User IDs does not include an implicit erase cycle like the EEPROM/CONFIG words. Hence, the user needs to clear the memory location pointed by TBLPTR, first by setting the FREE bit and executing the write command. An unlock sequence is required before setting the writing command. A single User ID byte is cleared at once (set to 0xff). CPU execution is stalled and, at the completion of the write cycle, the WR bit is cleared in hardware, the NVM Interrupt Flag (NVMIF) bit is set and the CPU resumes operation.

Once the User ID byte is cleared, the user can now write the new value to that location. To do this, the user needs to execute the TBLWT instruction followed by executing the write command. An unlock sequence is required before setting the writing command. A single User ID byte is written at once. CPU execution is stalled and, at the completion of the write cycle, the WR bit is cleared in hardware and the NVM Interrupt Flag (NVMIF) bit is set. The new User ID value takes effect when the CPU resumes operation.

During the above operations, if TBLPTR points to an invalid address location (see Table 13-1), the WR bit is cleared without any effect and WRERR is set.

APPENDIX A: DOCUMENT REVISION HISTORY

Rev H Document (09/2021)

Added Module 4.7 I²C Start/Stop Flags.

Rev G Document (02/2021)

Added Module 12.1 Software Breakpoints.

Data Sheet Clarifications:

Changed Module DC and AC Characteristics Graphs and Charts to Electrical Specifications. Changed figure 45-20 to 44-5. Added Module Nonvolatile Memory (NVM) Control.

Minor corrections.

Rev F Document (10/2019)

Added Silicon Revision A4. Added Modules 2.4 ADC Conversion; 3.9 Auto-Baud; 4.6 I²C Receive Buffer; and 11.1 MOVFF/MOVSF Instruction.

Data Sheet Clarifications:

DC and AC Characteristics Graphs and Charts: Correction to Figure 45-20 IDD, HFINTOSC Doze Mode, Fosc = 16 MHz, PIC18F24/25K42 Only.

Rev E Document (11/2018)

Remove A2 from Affected Silicon Revisions in ADC Conversion.

Rev D Document (11/2018)

Added Modules 1.2: DMA in Doze Mode; 2.2 ADC Conversion; and 2.3 Burst Average Mode Double Sampling. Added new Modules 8: NVM Control, 9: WWDT, and 10: Power-Saving Operation Modes.

Updated 3.4.

Rev C Document (02/2018)

Added Silicon Revision A2. Added 3.4 Baud Rate Generator Speed Select; 3.5 Stop Bit Interrupt Flag – renumbered sections.

Other minor corrections.

Rev B Document (07/2017)

Added Module 6: SMT and Module 7: Electrical Specifications for LF Devices Only to Silicon Errata Issues. Other minor corrections.

Rev A Document (01/2017)

Initial release of this document.

Note the following details of the code protection feature on Microchip products:

- Microchip products meet the specifications contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is secure when used in the intended manner, within operating specifications, and under normal conditions.
- Microchip values and aggressively protects its intellectual property rights. Attempts to breach the code protection features of Microchip product is strictly prohibited and may violate the Digital Millennium Copyright Act.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of its code. Code protection does not
 mean that we are guaranteeing the product is "unbreakable". Code protection is constantly evolving. Microchip is committed to
 continuously improving the code protection features of our products.

This publication and the information herein may be used only with Microchip products, including to design, test, and integrate Microchip products with your application. Use of this information in any other manner violates these terms. Information regarding device applications is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. Contact your local Microchip sales office for additional support or, obtain additional support at https://www.microchip.com/en-us/support/design-help/client-support-services.

THIS INFORMATION IS PROVIDED BY MICROCHIP "AS IS". MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION INCLUDING BUT NOT LIMITED TO ANY IMPLIED WARRANTIES OF NON-INFRINGEMENT, MERCHANTABILITY, AND FITNESS FOR A PARTICULAR PURPOSE, OR WARRANTIES RELATED TO ITS CONDITION, QUALITY, OR PERFORMANCE.

IN NO EVENT WILL MICROCHIP BE LIABLE FOR ANY INDIRECT, SPECIAL, PUNITIVE, INCIDENTAL, OR CONSEQUENTIAL LOSS, DAMAGE, COST, OR EXPENSE OF ANY KIND WHATSOEVER RELATED TO THE INFORMATION OR ITS USE, HOWEVER CAUSED, EVEN IF MICROCHIP HAS BEEN ADVISED OF THE POSSIBILITY OR THE DAMAGES ARE FORESEEABLE. TO THE FULLEST EXTENT ALLOWED BY LAW, MICROCHIP'S TOTAL LIABILITY ON ALL CLAIMS IN ANY WAY RELATED TO THE INFORMATION OR ITS USE WILL NOT EXCEED THE AMOUNT OF FEES, IF ANY, THAT YOU HAVE PAID DIRECTLY TO MICROCHIP FOR THE INFORMATION.

Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

For information regarding Microchip's Quality Management Systems, please visit www.microchip.com/quality.

Trademarks

The Microchip name and logo, the Microchip logo, Adaptec, AnyRate, AVR, AVR logo, AVR Freaks, BesTime, BitCloud, CryptoMemory, CryptoRF, dsPIC, flexPWR, HELDO, IGLOO, JukeBlox, KeeLoq, Kleer, LANCheck, LinkMD, maXStylus, maXTouch, MediaLB, megaAVR, Microsemi, Microsemi logo, MOST, MOST logo, MPLAB, OptoLyzer, PIC, picoPower, PICSTART, PIC32 logo, PolarFire, Prochip Designer, QTouch, SAM-BA, SenGenuity, SpyNIC, SST, SST Logo, SuperFlash, Symmetricom, SyncServer, Tachyon, TimeSource, tinyAVR, UNI/O, Vectron, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

AgileSwitch, APT, ClockWorks, The Embedded Control Solutions Company, EtherSynch, Flashtec, Hyper Speed Control, HyperLight Load, IntelliMOS, Libero, motorBench, mTouch, Powermite 3, Precision Edge, ProASIC, ProASIC Plus, ProASIC Plus logo, Quiet-Wire, SmartFusion, SyncWorld, Temux, TimeCesium, TimeHub, TimePictra, TimeProvider, TrueTime, WinPath, and ZL are registered trademarks of Microchip Technology Incorporated in the LLS A

Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, Augmented Switching, BlueSky, BodyCom, CodeGuard, CryptoAuthentication, CryptoAutomotive, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, Espresso T1S, EtherGREEN, GridTime, IdealBridge, In-Circuit Serial Programming, ICSP, INICnet, Intelligent Paralleling, Inter-Chip Connectivity, JitterBlocker, Knob-on-Display, maxCrypto, maxView, memBrain, Mindi, MiWi, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, NVM Express, NVMe, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PowerSmart, PureSilicon, QMatrix, REAL ICE, Ripple Blocker, RTAX, RTG4, SAM-ICE, Serial Quad I/O, simpleMAP, SimpliPHY, SmartBuffer, SmartHLS, SMART-I.S., storClad, SQI, SuperSwitcher, SuperSwitcher II, Switchtec, SynchroPHY, Total Endurance, TSHARC, USBCheck, VariSense, VectorBlox, VeriPHY, ViewSpan, WiperLock, XpressConnect, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

 $\ensuremath{\mathsf{SQTP}}$ is a service mark of Microchip Technology Incorporated in the U.S.A.

The Adaptec logo, Frequency on Demand, Silicon Storage Technology, Symmcom, and Trusted Time are registered trademarks of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

 $\hbox{@ 2017-22, Microchip Technology Incorporated}$ and its subsidiaries.

All Rights Reserved.

ISBN: 978-1-5224-8990-0



Worldwide Sales and Service

AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200

Tel: 480-792-7200 Fax: 480-792-7277 Technical Support:

http://www.microchip.com/ support

Web Address: www.microchip.com

Atlanta Duluth, GA

Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

Boston

Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL

Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX

Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI

Tel: 248-848-4000

Houston, TX

Tel: 281-894-5983 Indianapolis Noblesville, IN

Tel: 317-773-8323 Fax: 317-773-5453 Tel: 317-536-2380

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608

Tel: 951-273-7800 Raleigh, NC

Tel: 919-844-7510 New York, NY

Tel: 631-435-6000 San Jose, CA

Tel: 408-735-9110 Tel: 408-436-4270

Canada - Toronto Tel: 905-695-1980 Fax: 905-695-2078

ASIA/PACIFIC

Australia - Sydney Tel: 61-2-9868-6733

China - Beijing Tel: 86-10-8569-7000

China - Chengdu Tel: 86-28-8665-5511

China - Chongqing Tel: 86-23-8980-9588

China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

China - Hangzhou Tel: 86-571-8792-8115

China - Hong Kong SAR Tel: 852-2943-5100

China - Nanjing Tel: 86-25-8473-2460

China - Qingdao Tel: 86-532-8502-7355

China - Shanghai Tel: 86-21-3326-8000

China - Shenyang Tel: 86-24-2334-2829

China - Shenzhen Tel: 86-755-8864-2200

China - Suzhou Tel: 86-186-6233-1526

China - Wuhan Tel: 86-27-5980-5300

China - Xian

Tel: 86-29-8833-7252 **China - Xiamen** Tel: 86-592-2388138

China - Zhuhai Tel: 86-756-3210040

ASIA/PACIFIC

India - Bangalore Tel: 91-80-3090-4444

India - New Delhi Tel: 91-11-4160-8631

India - Pune Tel: 91-20-4121-0141

Japan - Osaka

Tel: 81-6-6152-7160 Japan - Tokyo

Tel: 81-3-6880- 3770

Korea - Daegu Tel: 82-53-744-4301

Korea - Seoul Tel: 82-2-554-7200

Malaysia - Kuala Lumpur Tel: 60-3-7651-7906

Malaysia - Penang Tel: 60-4-227-8870

Philippines - Manila Tel: 63-2-634-9065

Singapore Tel: 65-6334-8870

Taiwan - Hsin Chu Tel: 886-3-577-8366

Taiwan - Kaohsiung Tel: 886-7-213-7830

Taiwan - Taipei Tel: 886-2-2508-8600

Thailand - Bangkok Tel: 66-2-694-1351

Vietnam - Ho Chi Minh Tel: 84-28-5448-2100

EUROPE

Austria - Wels Tel: 43-7242-2244-39 Fax: 43-7242-2244-393

Denmark - Copenhagen Tel: 45-4485-5910 Fax: 45-4485-2829

Finland - Espoo Tel: 358-9-4520-820

France - Paris
Tel: 33-1-69-53-63-20
Fax: 33-1-69-30-90-79

Germany - Garching Tel: 49-8931-9700

Germany - Haan Tel: 49-2129-3766400

Germany - Heilbronn Tel: 49-7131-72400

Germany - Karlsruhe Tel: 49-721-625370

Germany - Munich Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Germany - Rosenheim Tel: 49-8031-354-560

Israel - Ra'anana Tel: 972-9-744-7705

Italy - Milan Tel: 39-0331-742611 Fax: 39-0331-466781

Italy - Padova Tel: 39-049-7625286

Netherlands - Drunen Tel: 31-416-690399 Fax: 31-416-690340

Norway - Trondheim Tel: 47-7288-4388

Poland - Warsaw Tel: 48-22-3325737

Romania - Bucharest Tel: 40-21-407-87-50

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Gothenberg Tel: 46-31-704-60-40

Sweden - Stockholm Tel: 46-8-5090-4654

UK - Wokingham Tel: 44-118-921-5800 Fax: 44-118-921-5820